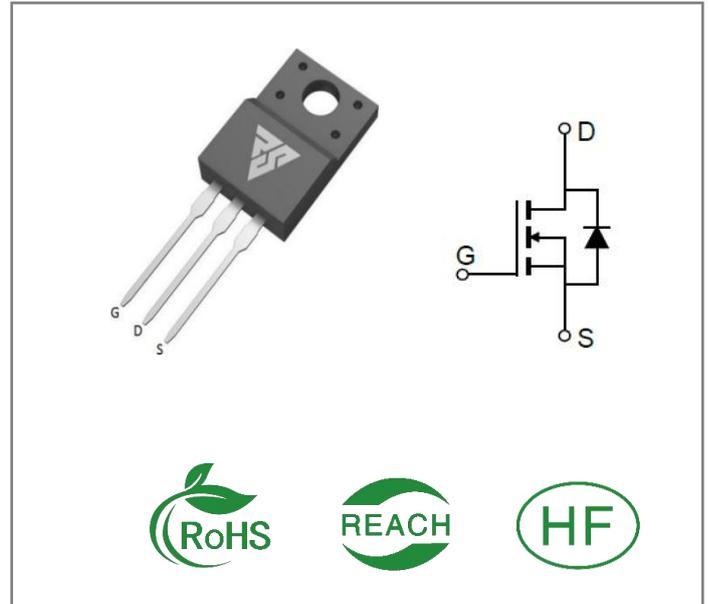


VDS	RDS(on)Typ	ID@25°C
800V	380mΩ	10A


Applications:

- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- Battery Chargers
- Motor Drives
- Pulsed Power Applications

Features:

- Wide Bandgap SiC MOSFET Technology
- Low On-Resistance with High Blocking Voltage
- Low Capacitances with High-Speed Switching
- Low Reverse Recovery (Qrr)
- Easy to Parallel and Simple to Drive
- Robust against Parasitic Turn on Even 0V Turn off Gate Voltage

Benefits:

- Reduced Switching Losses
- Increased System Switching Frequency
- Increased Power Density
- Reduction of Heat Sink Requirements
- Reduced EMI

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RSM080380F	TO-220F	RSM080380F	Tube	50 PCS

Maximum Ratings (TJ= 25°C unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions
VDS	Drain - Source Voltage	800	V	VGS=0V, ID=500μA
VGS	Gate - Source Voltage	-10/+22	V	Absolute maximum values
VGSOP	Recommended Operation Voltage of Gate to Source	0/+18	V	Recommended operational values
ID	Continuous Drain Current	10	A	VGS=15V, TC =25°C
IDM	Pulsed Drain Current	22	A	VGS=15V, TC =25°C
EAS	Single Pulsed Avalanche Energy	45	mJ	VDD=50V, L=10mH, IAS=3A
PD	Power Dissipation	24	W	TC =25°C, TJ =175°C
TJ, Tstg	Operating Junction and Storage Temperature	-55 to + 175	°C	

Electrical Characteristics (T_J= 25°C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V(BR)DSS	Drain-Source Breakdown Voltage	800			V	VGS=0V, ID=500μA	
VGS(th)	Gate Threshold Voltage	2.5	3.2	4.5	V	VGS= VDS, ID=1.8mA	
IDSS	Zero Gate Voltage Drain Current			10	μA	VDS=800V, VGS=0V	
IGSS	Gate-Source Leakage Current			250	nA	VGS=18V, VDS=0V	
RDS(on)	Drain-Source on-state Resistance		380	480	mΩ	VGS=15V, ID =10A	
			280	400		VGS=18V, ID =10A	
Ciss	Input Capacitance		254		pF	VGS=0V, VDS=500V f=1MHz, Tj=25°C	
Coss	Output Capacitance		20.2				
Crss	Reverse Transfer Capacitance		2.4				
RG	Gate Resistance		14.3		Ω	f=1 MHz, VAC=25mV	
Qg	Total Gate Charge		21.3		nC	VDS=500V VGS=0/+15V ID=5A	
Qgs	Gate to Source Charge		6.7				
Qgd	Gate to Drain Charge		11.5				
td(on)	Turn-On Delay Time		24		ns	VDD=500V VGS =0/15V ID=5A RG(ext)=10Ω	
tr	Rise Time		42				
td(off)	Turn-Off Delay Time		26.8				
tf	Fall Time		76				

Reverse Diode Characteristics (T_J= 25°C unless otherwise specified)

Symbol	Parameter	Typ.	Max	Unit	Test Conditions	Note
VSD	Diode Forward Voltage	3.5		V	VGS=0V, ISD =3A	
IS	Continuous Diode Forward Current		10	A	VGS=0V, Tj= 25°C	
trr	Reverse Recovery time	17.8		ns	VGS=0V, ISD=5A VR=500V, Tj=25°C di/dt=530A/us	
Qrr	Reverse Recovery Charge	33.7		nC		
Irrm	Peak Reverse Recovery Current	3.5		A		

Thermal Characteristics (T_J= 25°C unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions
RθJC	Thermal Resistance from Junction to Case	6.25		°C/W	

Typical Feature Curve

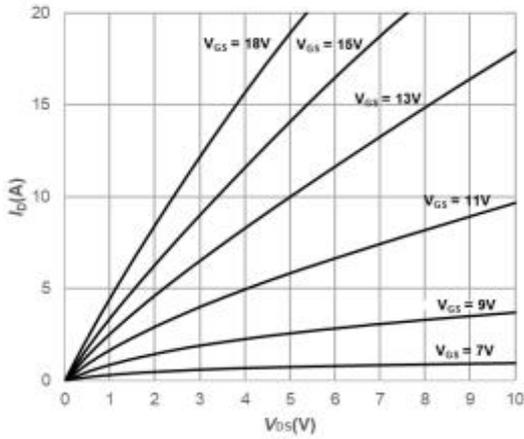


Fig1. Output Characteristics $T_j=25^{\circ}\text{C}$

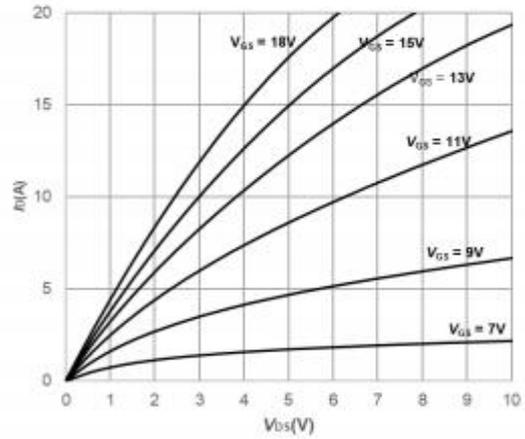


Fig2. Output Characteristics $T_j=175^{\circ}\text{C}$

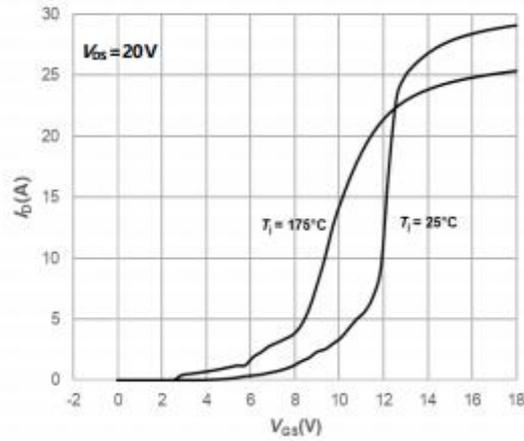


Fig3. Typical Transfer Characteristics

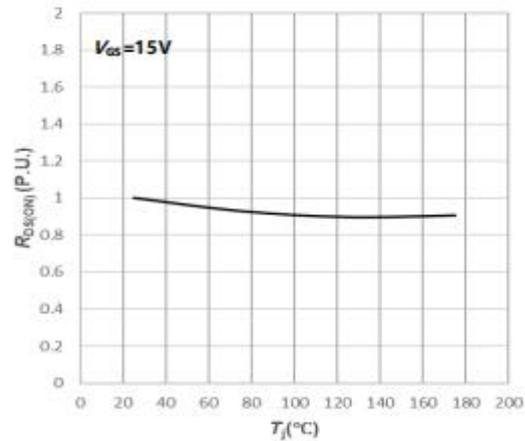


Fig4. Normalized On-Resistance vs. Temperature

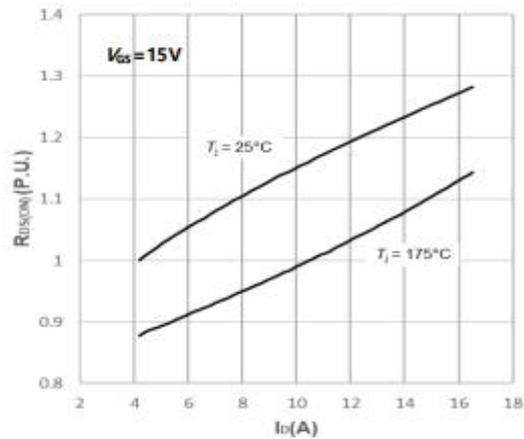


Fig5. Normalized On-Resistance vs. Drain Current For Various Temperatures

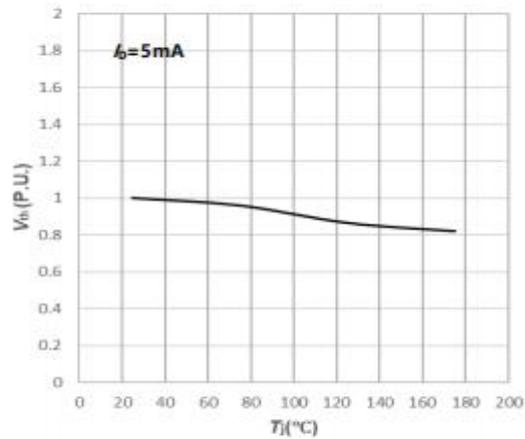


Fig6. Normalized Threshold Voltage vs. Temperature

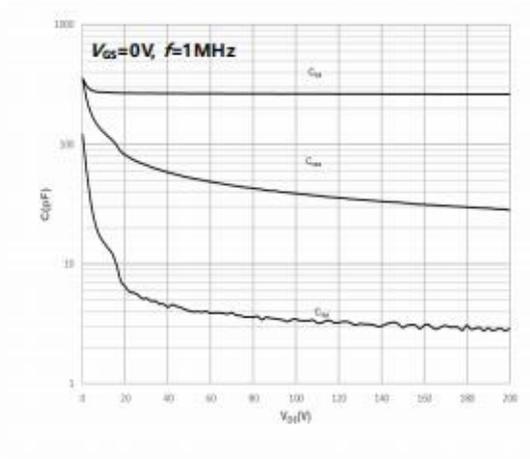


Fig7. Capacitances vs. Drain-Source Voltage (0-200V)

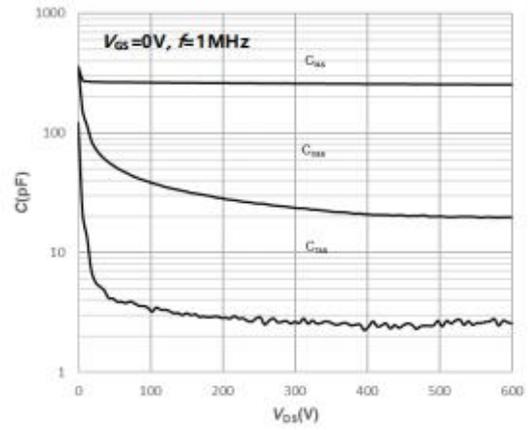


Fig8. Capacitances vs. Drain-Source Voltage (0-600V)

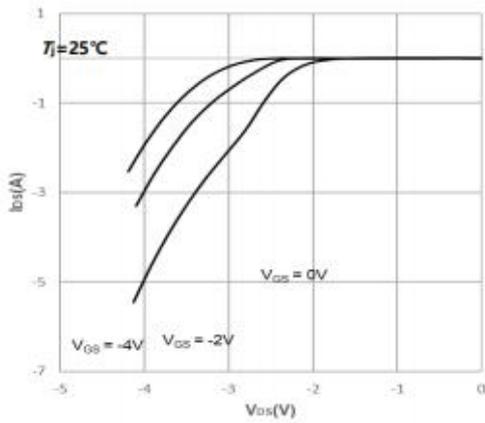
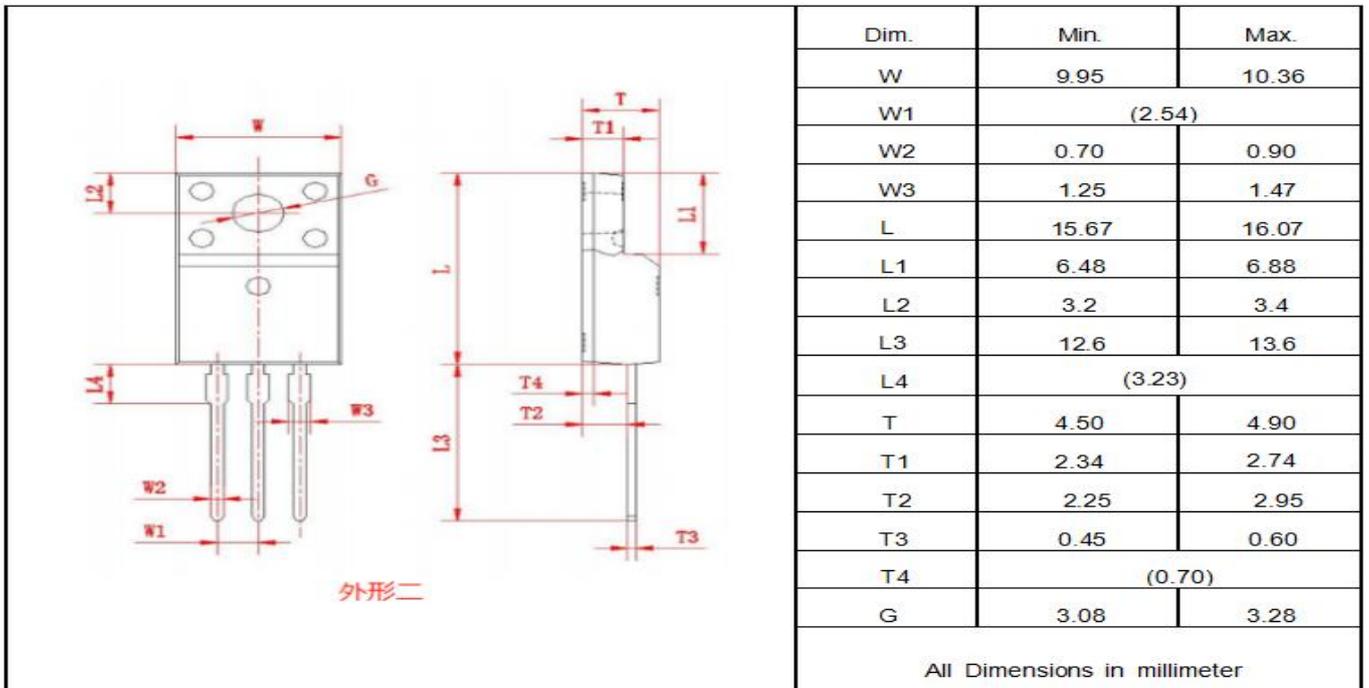
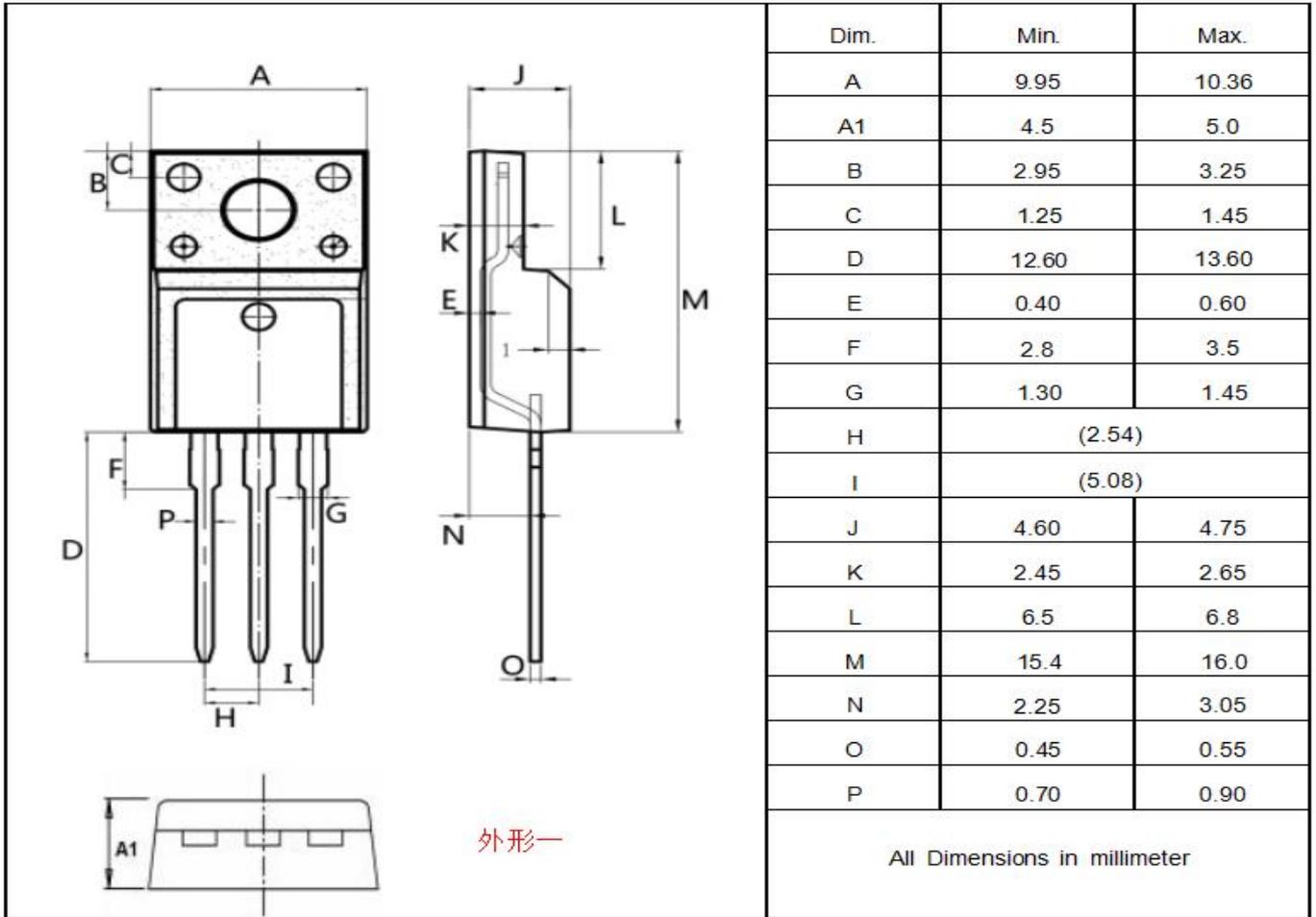


Fig9. Body Diode Characteristics

Package outline drawing(TO-220F Unit: mm)



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2.A critical component is any component of a life support device or system whose failure to system whose failure to perform can be reasonably expected to cause the failure of the life support device or system,or to affect its safety or effectiveness.